

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/780,029	ADAMSKI ET AL.
Examiner	Art Unit	
TAN Q. NGUYEN	3661	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
701	211,207 209,210	7/21/2006	TN
340	995.17		
	995.24		